TEXAS INSTRUMENTS

Data sheet acquired from Harris Semiconductor SCHS222C

February 1998 - Revised October 2003

Features

- Independent Asynchronous Inputs and Outputs
- Expandable in Either Direction
- Reset Capability
- · Status Indicators on Inputs and Outputs
- Three-State Outputs
- Shift-Out Independent of Three-State Control
- Fanout (Over Temperature Range)
 - Standard Outputs 10 LSTTL Loads
- Bus Driver Outputs 15 LSTTL Loads
- + Wide Operating Temperature Range . . . -55°C to 125°C
- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- HC Types
 - 2V to 6V Operation
 - High Noise Immunity: N_{IL} = 30%, N_{IH} = 30% of V_{CC} at V_{CC} = 5V
- HCT Types
 - 4.5V to 5.5V Operation
 - Direct LSTTL Input Logic Compatibility, V_{IL}= 0.8V (Max), V_{IH} = 2V (Min)
 - CMOS Input Compatibility, $I_I \leq 1 \propto A$ at V_{OL} , V_{OH}

Applications

- Bit-Rate Smoothing
- CPU/Terminal Buffering
- Data Communications
- Peripheral Buffering
- Line Printer Input Buffers
- Auto-Dialers
- CRT Buffer Memories
- Radar Data Acquisition

CD54HC40105, CD74HC40105, CD54HCT40105, CD74HCT40105

High-Speed CMOS Logic 4-Bit x 16-Word FIFO Register

Description

The 'HC40105 and 'HCT40105 are high-speed silicon-gate CMOS devices that are compatible, except for "shift-out" circuitry, with the CD40105B. They are low-power first-in-out (FIFO) "elastic" storage registers that can store 16 four-bit words. The 40105 is capable of handling input and output data at different shifting rates. This feature makes it particularly useful as a buffer between asynchronous systems.

Each work position in the register is clocked by a control flipflop, which stores a marker bit. A "1" signifies that the position's data is filled and a "0" denotes a vacancy in that position. The control flip-flop detects the state of the preceding flip-flop and communicates its own status to the succeeding flip-flop. When a control flip-flop is in the "0" state and sees a "1" in the preceeding flip-flop, it generates a clock pulse that transfers data from the preceding four data latches into its own four data latches and resets the preceding flip-flop to "0". The first and last control flip-flops have buffered outputs. Since all empty locations "bubble" automatically to the input end, and all valid data ripple through to the output end, the status of the first control flip-flop (DATA-IN READY) indicates if the FIFO is full, and the status of the last flip-flop (DATA-OUT READY) indicates if the FIFO contains data. As the earliest data are removed from the bottom of the data stack (the output end), all data entered later will automatically propagate (ripple) toward the output.

Ordering Information

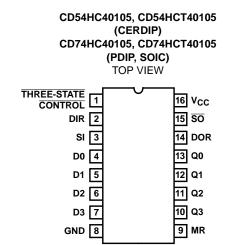
PART NUMBER	TEMP. RANGE (^o C)	PACKAGE
CD54HC40105F3A	-55 to 125	16 Ld CERDIP
CD54HCT40105F3A	-55 to 125	16 Ld CERDIP
CD74HC40105E	-55 to 125	16 Ld PDIP
CD74HC40105M	-55 to 125	16 Ld SOIC
CD74HC40105MT	-55 to 125	16 Ld SOIC
CD74HC40105M96	-55 to 125	16 Ld SOIC
CD74HCT40105E	-55 to 125	16 Ld PDIP
CD74HCT40105M	-55 to 125	16 Ld SOIC
CD74HCT40105MT	-55 to 125	16 Ld SOIC
CD74HCT40105M96	-55 to 125	16 Ld SOIC

NOTE: When ordering, use the entire part number. The suffix 96 denotes tape and reel. The suffix T denotes a small-quantity reel of 250.

CAUTION: These devices are sensitive to electrostatic discharge. Users should follow proper IC Handling Procedures.

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Pinout



Loading Data

Data can be entered whenever the DATA-IN READY (DIR) flag is high, by a low to high transition on the SHIFT-IN (SI) input. This input must go low momentarily before the next word is accepted by the FIFO. The DIR flag will go low momentarily, until the data have been transferred to the second location. The flag will remain low when all 16-word locations are filled with valid data, and further pulses on the SI input will be ignored until DIR goes high.

Unloading Data

As soon as the first word has rippled to the output, the dataout ready output (DOR) goes HIGH and data of the first word is available on the outputs. Data of other words can be removed by a negative-going transition on the shift-out input (\overline{SO}) . This negative-going transition causes the DOR signal to go LOW while the next word moves to the output. As long as valid data is available in the FIFO, the DOR signal will go high again, signifying that the next word is ready at the output. When the FIFO is empty, DOR will remain LOW, and any further commands will be ignored until a "1" marker ripples down to the last control register and DOR goes HIGH. If during unloading SI is HIGH, (FIFO is full) data on the data input of the FIFO is entered in the first location.

Master Reset

A high on the MASTER RESET (MR) sets all the control logic marker bits to "0". DOR goes low and DIR goes high. The contents of the data register are not changed, only declared invalid, and will be superseded when the first word is loaded. Thus, MR does not clear data within the register but only the control logic. If the shift-in flag (SI) is HIGH during the master reset pulse, data present at the input (D0 to D3) are immediately moved into the first location upon completion of the reset process.

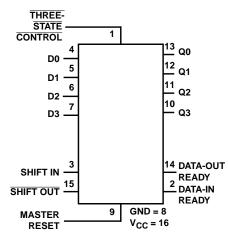
Three-State Outputs

In order to facilitate data busing, three-state outputs (Q0 to Q3) are provided on the data output lines, while the load condition of the register can be detected by the state of the DOR output. A HIGH on the three-state control flag (output enable input OE) forces the outputs into the high-impedance OFF-state mode. Note that the shift-out signal, unlike that in the CD40105B, is independent of the three-state output control. In the CD40105B, the three-state control must not be shifted from High to Low when the shift-out signal is Low (data loss would occur). In the high-speed CMOS version this restriction has been eliminated.

Cascading

The 40105 can be cascaded to form longer registers simply by connecting the DIR to SO and DOR to SI. In the cascaded mode, a MASTER RESET pulse must be applied after the supply voltage is turned on. For words wider than four bits, the DIR and the DOR outputs must be gated together with AND gates. Their outputs drive the SI and SO inputs in parallel, if expanding is done in both directions (see Figures 12 and 13).

Functional Diagram



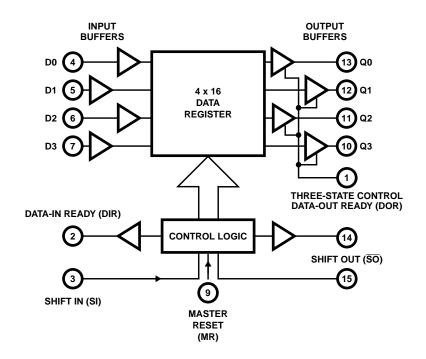
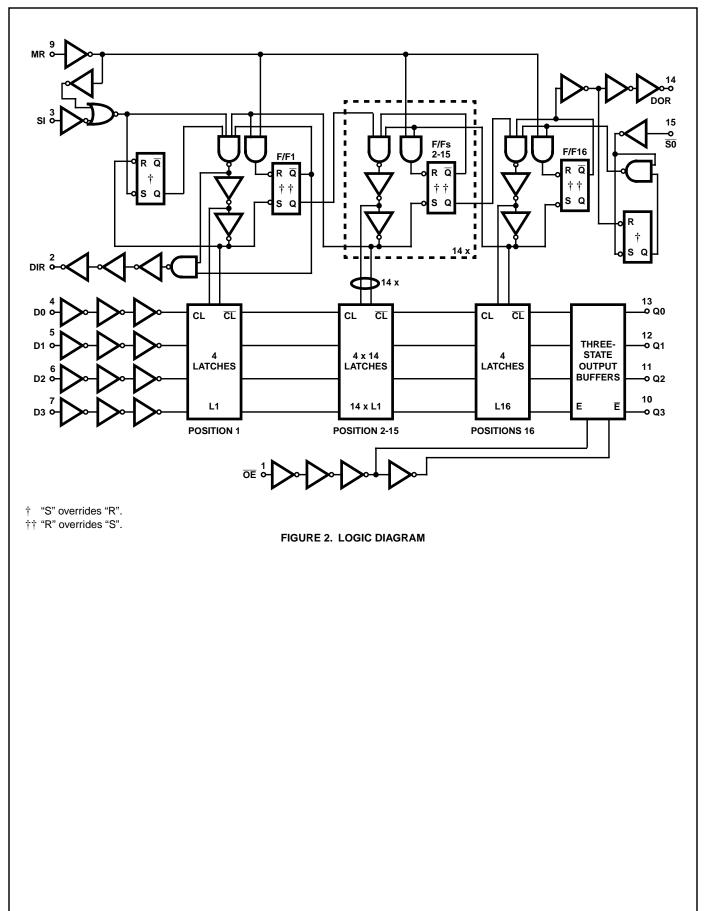


FIGURE 1. FUNCTIONAL BLOCK DIAGRAM



Absolute Maximum Ratings

DC Supply Voltage, V _{CC}
For $V_I < -0.5V$ or $V_I > V_{CC} + 0.5V$ ±20mA
DC Output Diode Current, IOK
For $V_0 < -0.5V$ or $V_0 > V_{CC} + 0.5V$ ±20mA
DC Output Source or Sink Current per Output Pin, IO
For $V_0 > -0.5V$ or $V_0 < V_{CC} + 0.5V$
DC V _{CC} or Ground Current, I _{CC} ±50mA

Operating Conditions

Temperature Range (T _A)55 ^o C to 125 ^o C Supply Voltage Range, V _{CC}
HC Types
HCT Types
DC Input or Output Voltage, V _I , V _O V to V _{CC}
Input Rise and Fall Time
2V
4.5V 500ns (Max)
6V

Thermal Information

Thermal Resistance (Typical, Note 1)	θ_{JA} (^o C/W)
E (PDIP) Package	
M (SOIC) Package	73
Maximum Junction Temperature	150 ⁰ С
Maximum Storage Temperature Range6	
Maximum Lead Temperature (Soldering 10s)	
(SOIC - Lead Tips Only)	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. The package thermal impedance is calculated in accordance with JESD 51-7.

DC Electrical Specifications

		TES CONDI		v _{cc}		25 ⁰ C		-40 ⁰ C 1	O 85°C	-55°C TO 125°C		4
PARAMETER	SYMBOL	V _I (V)	I _O (mA)			TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES						_	_			_		_
High Level Input	VIH	-	-	2	1.5	-	-	1.5	-	1.5	-	V
Voltage				4.5	3.15	-	-	3.15	-	3.15	-	V
				6	4.2	-	-	4.2	-	4.2	-	V
Low Level Input	VIL	-	-	2	-	-	0.5	-	0.5	-	0.5	V
Voltage				4.5	-	-	1.35	-	1.35	-	1.35	V
				6	-	-	1.8	-	1.8	-	1.8	V
High Level Output	VOH	V _{IH} or V _{IL}	-0.02	2	1.9	-	-	1.9	-	1.9	-	V
Voltage CMOS Loads		-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V	
			-0.02	6	5.9	-	-	5.9	-	5.9	-	V
High Level Output	Level Output		-	-	-	-	-	-	-	-	-	V
Voltage TTL Loads			-4	4.5	3.98	-	-	3.84	-	3.7	-	V
			-5.2	6	5.48	-	-	5.34	-	5.2	-	V
Low Level Output	V _{OL}	$V_{\text{IH}} \text{ or } V_{\text{IL}}$	0.02	2	-	-	0.1	-	0.1	-	0.1	V
Voltage CMOS Loads			0.02	4.5	-	-	0.1	-	0.1	-	0.1	V
			0.02	6	-	-	0.1	-	0.1	-	0.1	V
Low Level Output			-	-	-	-	-	-	-	-	-	V
Voltage TTL Loads			4	4.5	-	-	0.26	-	0.33	-	0.4	V
			5.2	6	-	-	0.26	-	0.33	-	0.4	V
Input Leakage Current	lı	V _{CC} or GND	-	6	-	-	±0.1	-	±1	-	±1	∝A
Quiescent Device Current	Icc	V _{CC} or GND	0	6	-	-	8	-	80	-	160	∝A

DC Electrical Specifications (Continued)

		TES CONDI		V _{CC}		25 ⁰ C		-40°C T	O 85°C	-55°C T	O 125°C	
PARAMETER	SYMBOL	V _I (V)	I _O (mA)	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
Three-State Leakage Current	I _{OZ}	V _{IL} or V _{IH}	V _O = V _{CC} or GND	6	-	-	±0.5	-	±5	-	±10	∝A
HCT TYPES					-							
High Level Input Voltage	V _{IH}	-	-	4.5 to 5.5	2	-	-	2	-	2	-	V
Low Level Input Voltage	V _{IL}	-	-	4.5 to 5.5	-	-	0.8	-	0.8	-	0.8	V
High Level Output Voltage CMOS Loads	V _{OH}	V _{IH} or V _{IL}	-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V
High Level Output Voltage TTL Loads			-4	4.5	3.98	-	-	3.84	-	3.7	-	V
Low Level Output Voltage CMOS Loads	V _{OL}	V _{IH} or V _{IL}	0.02	4.5	-	-	0.1	-	0.1	-	0.1	V
Low Level Output Voltage TTL Loads			4	4.5	-	-	0.26	-	0.33	-	0.4	V
Input Leakage Current	lı	V _{CC} and GND	0	5.5	-	-	±0.1	-	±1	-	±1	∝A
Quiescent Device Current	Icc	V _{CC} or GND	0	5.5	-	-	8	-	80	-	160	∝A
Three-State Leakage Current	I _{OZ}	V _{IL} or V _{IH}	V _O = V _{CC} or GND	5.5	-	-	±0.5	-	±5	-	±10	∝A
Additional Quiescent Device Current Per Input Pin: 1 Unit Load	ΔI _{CC} (Note 2)	V _{CC} -2.1	-	4.5 to 5.5	-	100	360	-	450	-	490	∝A

NOTE:

2. For dual-supply systems theoretical worst case (V_I = 2.4V, V_{CC} = 5.5V) specification is 1.8mA.

HCT Input Loading Table

INPUT	UNIT LOADS
ŌĒ	0.75
SI, SO	0.4
Dn	0.3
MR	1.5

NOTE: Unit Load is ΔI_{CC} limit specified in DC Electrical Table, e.g., 360~A max at 25°C.

Prerequisite for Switching Specifications

			25	oc	-40 ⁰ C T	О 85 ⁰ С	-55 ⁰ C T	O 125 ⁰ C	
PARAMETER	SYMBOL	V _{CC} (V)	MIN	MAX	MIN	МАХ	MIN	MAX	
HC TYPES					1	<u>.</u>	<u>.</u>		!
SI Pulse Width	t _W	2	80	-	100	-	120	-	ns
HIGH or LOW		4.5	16	-	20	-	24	-	ns
		6	14	-	17	-	20	-	ns
SO Pulse Width	t _W	2	120	-	150	-	180	-	ns
HIGH or LOW		4.5	24	-	30	-	36	-	ns
		6	20	-	26	-	31	-	ns
DIR Pulse Width	t _W	2	200	-	250	-	300	-	ns
HIGH or LOW		4.5	40	-	50	-	60	-	ns
		6	34	-	43	-	51	-	ns
DOR Pulse Width	t _W	2	200	-	250	-	300	-	ns
HIGH or LOW		4.5	40	-	50	-	60	-	ns
		6	34	-	43	-	51	-	ns
MR Pulse Width HIGH	t _W	2	120	-	150	-	180	-	ns
		4.5	24	-	30	-	36	-	ns
		6	20	-	26	-	31	-	ns
Removal Time	^t REM	2	50	-	65	-	75	-	ns
MR to SI		4.5	10	-	13	-	15	-	ns
		6	9	-	11	-	13	-	ns
Set-Up Time	ts∪	2	5	-	5	-	5	-	ns
Dn to SI		4.5	5	-	5	-	5	-	ns
		6	5	-	5	-	5	-	ns
Hold Time	t _H	2	125	-	155	-	190	-	ns
Dn to SI		4.5	25	-	31	-	38	-	ns
		6	21	-	26	-	32	-	ns
Maximum Pulse Frequency	f _{MAX}	2	3	-	2	-	2	-	MHz
SI, SO		4.5	15	-	12	-	10	-	MHz
		6	18	-	14	-	12	-	MHz
HCT TYPES				•	•				
SI Pulse Width HIGH or LOW	t _W	4.5	16	-	20	-	24	-	ns
SO Pulse Width HIGH or LOW	t _W	4.5	16	-	20	-	24	-	ns
DIR Pulse Width HIGH or LOW	t _W	4.5	40	-	50	-	60	-	ns
DOR Pulse Width HIGH or LOW	t _W	4.5	40	-	50	-	60	-	ns
MR Pulse Width HIGH	t _W	4.5	24	-	30	-	36	-	ns
Removal Time MR to SI	t _{REM}	4.5	15	-	19	-	22	-	ns
Set-Up Time Dn to SI	ts∪	4.5	0	-	0	-	0	-	ns
Hold Time Dn to SI	t _H	4.5	25	-	31	-	38	-	ns
Maximum Pulse Frequency SI, SO	f _{MAX}	4.5	15	-	12	-	10	-	MHz

Switching Specifications Input tr, tf = 6ns

		TEST	Vcc		25°C		-40 ⁰ C 1	0 85°C	-55 ⁰ C T	0 125 ⁰ C	
PARAMETER	SYMBOL	CONDITIONS	vcc (V)	MIN	ТҮР	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES	-	-		-							
Propagation Delay	^t PHL,	C _L = 50pF	2	-	-	175	-	220	-	265	ns
MR to DIR, DOR	^t PLH	$C_L = 50 pF$	4.5	-	-	35	-	44	-	53	ns
		C _L = 15pF	5	-	15	-	-	-	-	-	ns
		$C_L = 50 pF$	6	-	-	30	-	37	-	45	ns
SI to DIR	^t PHL,	$C_L = 50 pF$	2	-	-	210	-	265	-	315	ns
	^t PLH	C _L = 50pF	4.5	-	-	42	-	53	-	63	ns
		C _L = 15pF	5	-	18	-	-	-	-	-	ns
		C _L = 50pF	6	-	-	36	-	45	-	54	ns
SO to DOR	t _{PHL,}	C _L = 50pF	2	-	-	210	-	265	-	315	ns
	^t PLH	C _L = 50pF	4.5	-	-	42	-	53	-	63	ns
		C _L = 15pF	5	-	18	-	-	-	-	-	ns
		C _L = 50pF	6	-	-	36	-	45	-	54	ns
SO to Qn	t _{PHL,}	C _L = 50pF	2	-	-	400	-	500	-	600	ns
	^t PLH	C _L = 50pF	4.5	-	-	80	-	100	-	120	ns
		C _L = 15pF	5	-	35	-	-	-	-	-	ns
		C _L = 50pF	6	-	-	68	-	85	-	102	ns
Propagation Delay/Ripple thru Delay SI to DOR	t _{PLH}	C _L = 50pF	2	-	-	2000	-	2500	-	3000	ns
			4.5	-	-	400	-	500	-	600	ns
			6	-	-	340	-	425	-	510	ns
Propagation Delay/Ripple thru	t _{PLH}	C _L = 50pF	2	-	-	2500	-	3125	-	3750	ns
Delay SO to DIR			4.5	-	-	500	-	625	-	750	ns
			6	-	-	425	-	532	-	638	ns
Propagation Delay/Ripple thru	t _{PLH}	C _L = 50pF	2	-	-	1500	-	1900	-	2250	ns
Delay SI to Qn			4.5	-	-	300	-	380	-	450	ns
			6	-	-	260	-	330	-	380	ns
Three-State Output Enable	t _{PZH} , t _{PZL}	C _L = 50pF	2	-	-	150	-	190	-	225	ns
OE to Q _n			4.5	-	-	30	-	38	-	45	ns
			6	-	-	26	-	33	-	38	ns
Three-State Output Disable	t _{PHZ} , t _{PLZ}	C _L = 50pF	2	-	-	140	-	175	-	210	ns
OE to Qn	,	C _L = 50pF	4.5	-	-	28	-	35	-	42	ns
		C _L = 50pF	6	-	-	24	-	30	-	36	ns
Output Transition Time	t _{TLH} , t _{THL}	C _L = 50pF	2	-	-	75	-	95	-	110	ns
			4.5	-	-	15	-	19	-	22	ns
			6	-	-	13	-	16	-	19	ns
Maximum SI, SO Frequency	f _{MAX}	C _L = 15pF	5	-	32	-	-	-	-	-	MHz
Input Capacitance	C _{IN}	$C_L = 50 pF$	-	-	-	10	-	10	-	10	pF
Power Dissipation Capacitance (Notes 3, 4)		C _L = 15pF	5	-	83	-	-	-	-	-	pF

		TEST	v _{cc}		25 ⁰ C		-40 ⁰ C 1	O 85 ⁰ C	-55 ⁰ C T	O 125 ⁰ C	
PARAMETER	SYMBOL	CONDITIONS	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
Three-State Output Capacitance	CO	C _L = 50pF	-	-	-	15	-	15	-	15	pF
HCT TYPES											
Propagation Delay Time	t _{PLH,}	C _L = 50pF	4.5	-	-	36	-	45	-	54	ns
MR to DIR, DOR	^t PHL	C _L = 15pF	5	-	15	-	-	-	-	-	ns
SI to DIR	t _{PLH,}	C _L = 50pF	4.5	-	-	42	-	53	-	63	ns
	^t PHL	C _L =15pF	5	-	18	-	-	-	-	-	ns
SO to DOR	t _{PLH,}	C _L = 50pF	4.5	-	-	42	-	53	-	63	ns
	^t PHL	C _L =15pF	5	-	18	-	-	-	-	-	ns
SO to Qn	t _{PLH,}	C _L = 50pF	4.5	-	-	80	-	100	-	120	ns
	^t PHL	C _L =15pF	5	-	35	-	-	-	-	-	ns
Propagation Delay/Ripple thru Delay SI to DOR	^t PLH	C _L = 50pF	4.5	-	-	400	-	500	-	600	ns
Propagation Delay/Ripple thru Delay SO to DIR	^t PLH	C _L = 50pF	4.5	-	-	500	-	625	-	750	ns
Propagation Delay/Ripple thru Delay SI to Qn	^t PLH	C _L = 50pF	4.5	-	-	300	-	380	-	450	ns
Three-State Output Enable $\overline{\text{OE}}$ to Q_n	^t PZH, ^t PZL	C _L = 50pF	4.5	-	-	35	-	44	-	53	ns
Three-State Output Disable OE to Qn	^t PHZ, ^t PLZ	C _L = 50pF	4.5	-	-	30	-	38	-	45	ns
Output Transition Time	t _{TLH} , t _{THL}	C _L = 50pF	4.5	-	-	15	-	19	-	22	ns
Maximum CP Frequency	f _{MAX}	C _L =15pF	5	-	32	-	-	-	-	-	MHz
Input Capacitance	C _{IN}	C _L = 50pF	-	-	-	10	-	10	-	10	pF
Power Dissipation Capacitance (Notes 3, 4)	C _{PD}	C _L =15pF	5	-	83	-	-	-	-	-	pF
Three-State Output Capacitance	CO	C _L = 50pF	-	-	-	15	-	15	-	15	pF

Switching Specifications Input tr. tr = 6ns (Continued)

NOTES:

C_{PD} is used to determine the dynamic power consumption, per package.
P_D = C_{PD} V_{CC}² f_i + Σ (C_L V_{CC}² f_o) where f_i = Input Frequency, f_o = Output Frequency, C_L = Output Load Capacitance, V_{CC} = Supply Voltage.

t_{WL} + t_{WH} =

1.3V

twн

t_f = 6ns

tтiн

90%

1.3V

t_{PL H}

зv

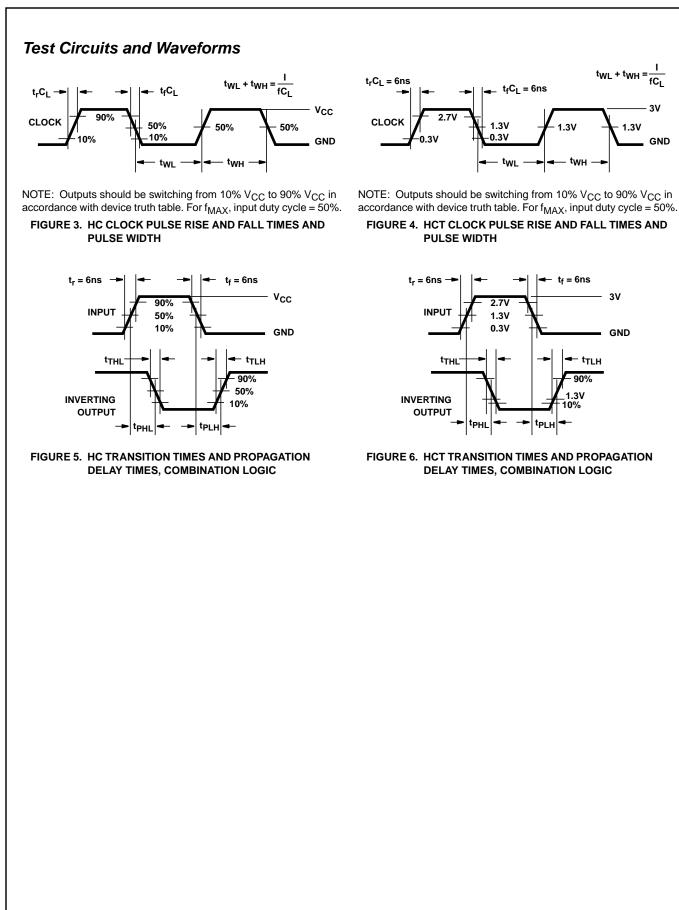
GND

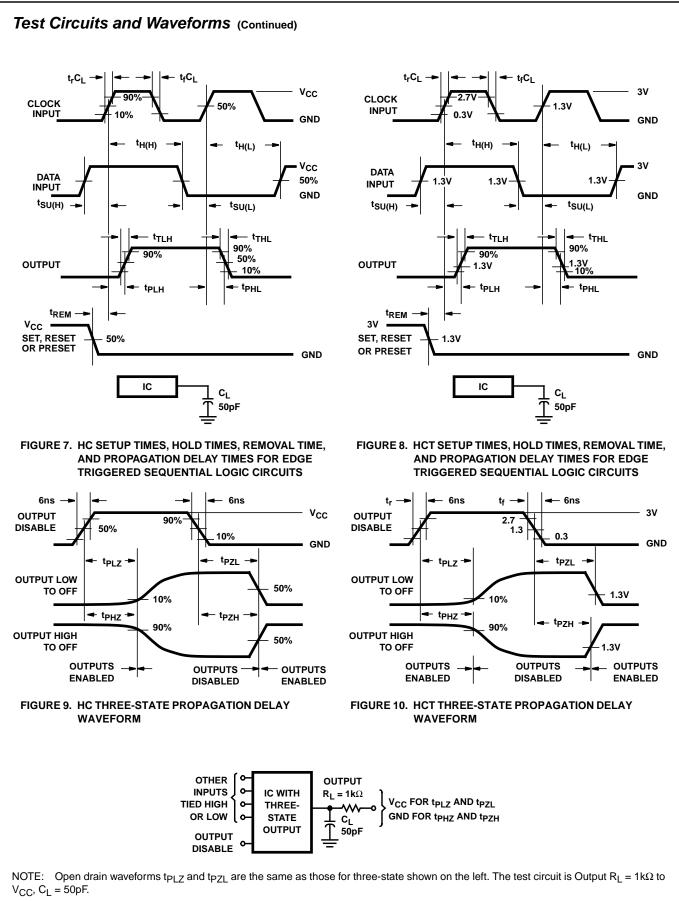
1.3V

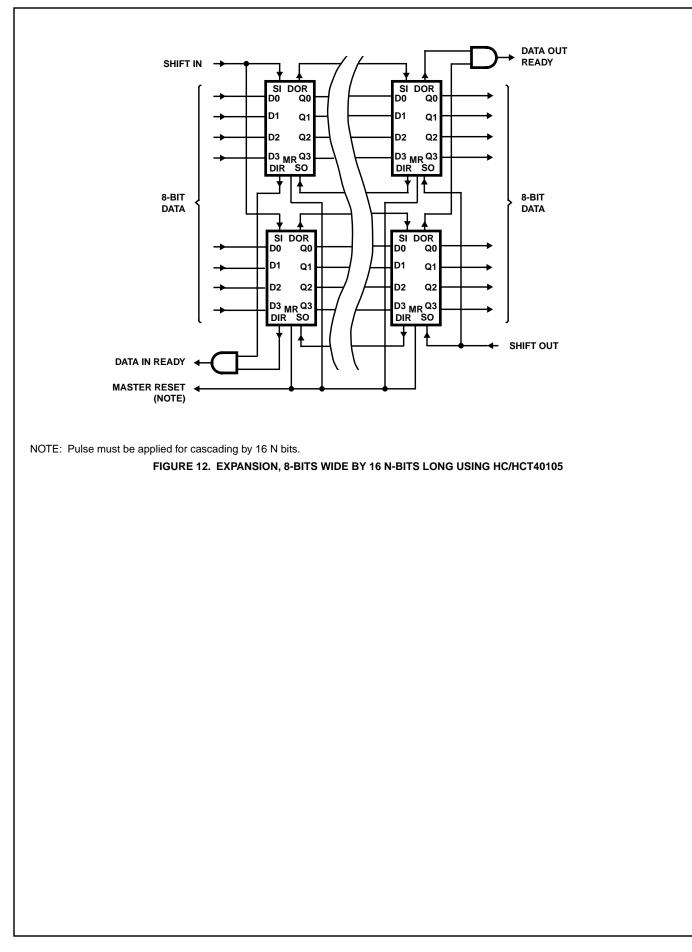
fCL

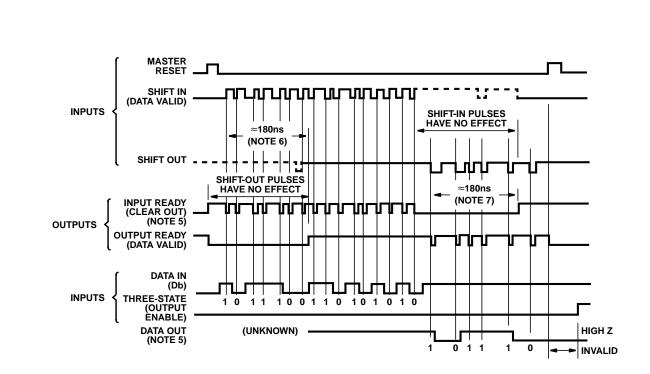
3V

GND









NOTES:

5. Data valid goes to high level in advance of the data out by a maximum of 38ns at V_{CC} = 4.5V for C_L = 50pF and T_A = 25°C.

- 6. At V_{CC} = 4.5V, ripple time from position 1 to position 16.
- 7. At V_{CC} = 4.5V, ripple time from position 16 to position 1.

FIGURE 13. TIMING DIAGRAM FOR THE CD74HC/HCT40105



PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	•	Eco Plan	Lead finish/	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	Ball material	(3)		(4/5)	
							(6)				
CD54HC40105F3A	ACTIVE	CDIP	J	16	1	Non-RoHS	SNPB	N / A for Pkg Type	-55 to 125	CD54HC40105F3A	Samples
						& Green					
CD74HC40105E	ACTIVE	PDIP	Ν	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC40105E	Samples
	-										1
CD74HC40105M	LIFEBUY	SOIC	D	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC40105M	
CD74HC40105M96	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC40105M	Samples
											Samples
CD74HCT40105E	ACTIVE	PDIP	Ν	16	25	RoHS & Green	NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT40105E	Samples
CD74HCT40105M	ACTIVE	SOIC	D	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT40105M	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



PACKAGE OPTION ADDENDUM

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OTHER QUALIFIED VERSIONS OF CD54HC40105, CD74HC40105 :

- Catalog : CD74HC40105
- Military : CD54HC40105

NOTE: Qualified Version Definitions:

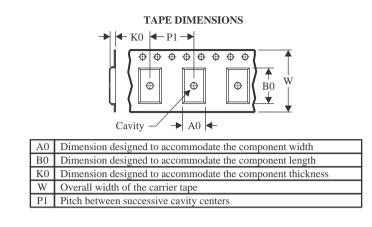
- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications



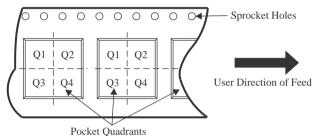
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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



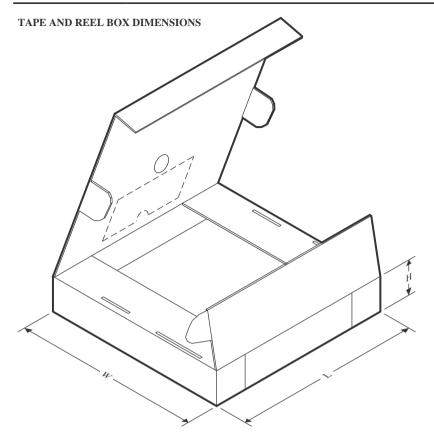
*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC40105M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1



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PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

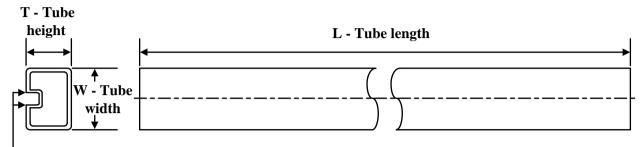
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HC40105M96	SOIC	D	16	2500	340.5	336.1	32.0

TEXAS INSTRUMENTS

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TUBE



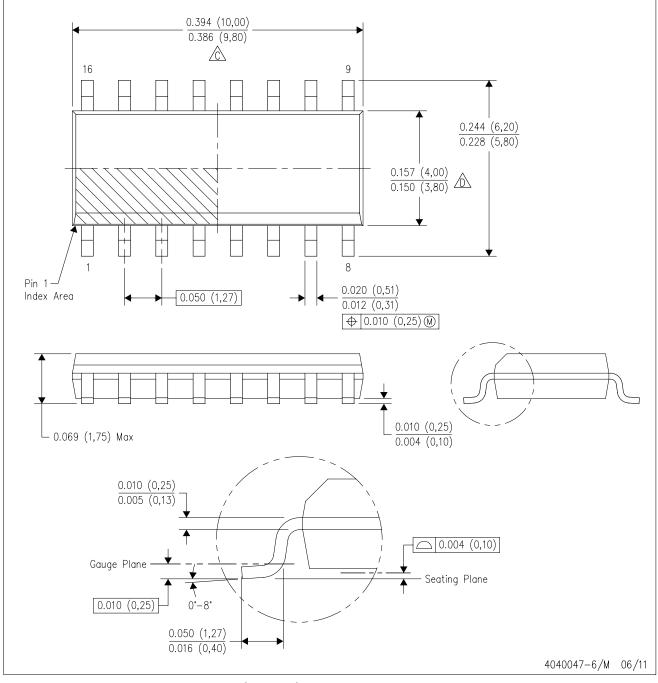
- B - Alignment groove width

*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
CD74HC40105E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HC40105E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HC40105M	D	SOIC	16	40	507	8	3940	4.32
CD74HCT40105E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT40105E	N	PDIP	16	25	506	13.97	11230	4.32
CD74HCT40105M	D	SOIC	16	40	507	8	3940	4.32

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



J (R-GDIP-T**) 14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



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